

<b>Notice of References Cited</b>	Application/Control No. 09/897,909	Applicant(s)/Patent Under Reexamination SATO ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0067564	04-2003	Sato, Yasuhiro	349/58
	B	US-6,201,586	03-2001	Nakayama, Tatsuya	349/58
	C	US-2002/0141194	10-2002	Wortman et al.	362/309
	D	US-2003/0053007	03-2003	Higashi, Shinji	349/65
	E	US-6,222,689	04-2001	Higuchi et al.	359/837
	F	US-6,322,225	11-2001	Koike, Yasuhiro	362/31
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-149254	06-1999	Japan	Mizutani	
	O	JP 8-114802	05-1996	Japan	Yoshimura	
	P	JP 8-129174	05-1996	Japan	Minami	
	Q	JP 6-51308	02-1994	Japan	Nishio et al	
	R	JP 11-121169	04-1999	Japan		
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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